Search Notes			
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Application/Control No.	Applicant(s)/Patent unde Reexamination	r
10/662,977	LEE, DONG-YANG	
Examiner	Art Unit	
Alan S Chan	2192	

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INTERFERENCE SEARCHED			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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(EAST) USPAT; USPGPUB; EPO; JPO; IBM_TDB; DERWENT PLUS; Inventor Search	1/31/2006	ASC		
updated EHST	7/12/06	ASC		
nydated EAST	2/26/07	Asc		